Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination			
10/790,803	TANAHASHI ET AL.			
Examiner	Art Unit			
Alain I Bashore	1762			

	SEARCHED				
Class	Subclass	Date	Examiner		
428	694TM 694TS	9/17/2006	АВ		
428	900;65.3	9/17/2006	AB		
428	65.7	9/17/2006	ab		
			·		
	·				
•			·		

INT	ITERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
427	599;598	9/17/2006	AB		
427	128	9/17/2006	AB		
428	694TM 694	9/17/2006	АВ		
428/900,	65.3,65.7	9/17/2006	ab		

SEARCH (INCLUDING SEAF		)
	DATE	EXMR
previous search updated	9/17/2006	АВ
Inventor name search	9/17/2006	АВ
·		